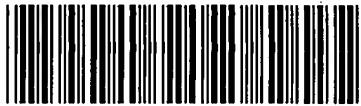


Search Notes**Application/Control No.**

10/672,304

Examiner

Tai Duong

Applicant(s)/Patent under Reexamination

CHO ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	42, 106	7/6/2007	TD
	107, 155		
	156, 157		
	43, 187		
349	110		
430	5, 7		
	321		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM TDB) see search history printout	7/6/2007	TD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner